	DEAN O. TAKAOKA	2817	Page 1 of 1	
Notice of References Cited	Examiner	Art Unit		
	10/596,286	Reexamination TOUJO ET AL.		
	Application/Control No.	Applicant(s)/Patent Under		

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,747,525	06-2004	lida et al.	333/116
	В	US-			
	C	US-			
	D	US-			
	Е	US-			
	F	US-			
	G	US-			
	Ι	US-			
	1	US-			
	J	US-			
	K	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Ø					
	R					
	S					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)	
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	V		
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	х		

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